SONY

# Diagonal 8.933mm (Type 1/1.8) Frame Readout CCD Image Sensor with Square Pixel for Color Cameras

#### Description

The ICX252AQ is a diagonal 8.933mm (Type 1/1.8) interline CCD solid-state image sensor with a square pixel array and 3.24M effective pixels. Frame readout allows all pixels' signals to be output independently within approximately 1/4.28 second.

Also, number of vertical pixels decimation allows output of 30 frames per second in high frame rate readout mode.

R, G, B primary color mosaic filters are used as the color filters, and at the same time high sensitivity and low dark current are achieved through the adoption of Super HAD CCD technology.

This chip is suitable for applications such as electronic still cameras, etc.

#### Features

- Supports frame readout
- High horizontal and vertical resolution
- Supports high frame rate readout mode: 30 frames/s, AF1 mode: 60 frames/s, 50 frames/s, AF2 mode: 120 frames/s, 100 frames/s
- Square pixel
- Horizontal drive frequency: 18MHz
- No voltage adjustments (reset gate and substrate bias are not adjusted.)
- R, G, B primary color mosaic filters on chip
- · High sensitivity, low dark current
- Continuous variable-speed shutter
- Excellent anti-blooming characteristics
- Exit pupil distance recommended range -20 to -100mm
- 20-pin high-precision plastic package

#### **Device Structure**

- Interline CCD image sensor
- Total number of pixels: 2140 (H) × 1560 (V) approx. 3.34M pixels
- 2088 (H) × 1550 (V) approx. 3.24M pixels Number of effective pixels:
- Number of active pixels:
- Number of recommended record pixels: 2048 (H) × 1536 (V) approx. 3.15M pixels diagonal 8.832mm
- Chip size:
- Unit cell size:
- · Optical black:
- Number of dummy bits:
- Substrate material:

#### aspect ratio 4:3 8.10mm (H) × 6.64mm (V) 3.45µm (H) × 3.45µm (V) Horizontal (H) direction: Front 4 pixels, rear 48 pixels Vertical (V) direction: Front 8 pixels, rear 2 pixels Horizontal 28 Vertical 1 (even fields only) Silicon

2080 (H) × 1542 (V) approx. 3.21M pixels diagonal 8.933mm

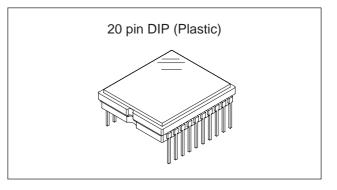
# Super HAD CCD

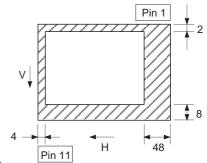
\*Super HAD CCD is a registered trademark of Sony Corporation. Super HAD CCD is a CCD that drastically improves sensitivity by introducing newly developed semiconductor technology by Sony Corporation into Sony's high-performance HAD (Hole-Accumulation Diode) sensor

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E00109-PS



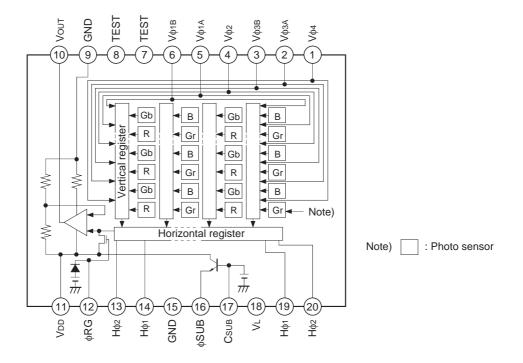


**Optical black position** (Top View)

ICX252A

# **Block Diagram and Pin Configuration**

(Top View)



## **Pin Description**

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	Vφ4	Vertical register transfer clock	11	Vdd	Supply voltage
2	Vфза	Vertical register transfer clock	12	φRG	Reset gate clock
3	Vфзв	Vertical register transfer clock	13	Hø2	Horizontal register transfer clock
4	Vφ2	Vertical register transfer clock	14	Ηφ1	Horizontal register transfer clock
5	Vφ1A	Vertical register transfer clock	15	GND	GND
6	Vф1в	Vertical register transfer clock	16	φSUB	Substrate clock
7	TEST	Test pin <sup>*1</sup>	17	Сѕив	Substrate bias*2
8	TEST	Test pin <sup>*1</sup>	18	VL	Protective transistor bias
9	GND	GND	19	Ηφ1	Horizontal register transfer clock
10	Vout	Signal output	20	Hø2	Horizontal register transfer clock

\*1 Leave this pin open.

\*2 DC bias is generated within the CCD, so that this pin should be grounded externally through a capacitance of 0.1µF.

# Absolute Maximum Ratings

	Item	Ratings	Unit	Remarks
	Vdd, Vout, $\phi RG - \phi SUB$	-40 to +12	V	
Against	Vφ1Α, Vφ1Β, Vφ3Α, Vφ3Β – φSUB	-50 to +15	V	
	V $\phi$ 2, V $\phi$ 4, VL – $\phi$ SUB	-50 to +0.3	V	
	Hφ1, Hφ2, GND – φSUB	-40 to +0.3	V	
	Csuв – фSUB	–25 to	V	
	Vdd, Vout, фRG, Csub – GND	-0.3 to +22	V	
Against	Vφ1Α, Vφ1Β, Vφ2, Vφ3Α, Vφ3Β, Vφ4 – GND	-10 to +18	V	
	Ηφ1, Ηφ2 – GND	-10 to +6.5	V	
A goingt \/	Vφ1Α, Vφ1Β, Vφ3Α, Vφ3Β – VL	-0.3 to +28	V	
Against V∟	Vφ2, Vφ4, Hφ1, Hφ2, GND – VL	-0.3 to +15	V	
	Voltage difference between vertical clock input pins	to +15	V	*1
Between input clock pins	Ηφ1 — Ηφ2	-6.5 to +6.5	V	
P	Ηφ1, Ηφ2 – Vφ4	-10 to +16	V	
Storage temperature		-30 to +80 °C		
Guaranteed temperatu	ire of performance	-10 to +60	°C	
Operating temperature		-10 to +75	°C	

 $^{*1}\,$  +24V (Max.) when clock width < 10µs, clock duty factor < 0.1%.

+16V (Max.) is guaranteed for turning on or off power supply.

## **Bias Conditions**

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Supply voltage	Vdd	14.55	15.0	15.45	V	
Protective transistor bias	VL		*1			
Substrate clock	φSUB		*2			
Reset gate clock	φRG		*2			

\*1 VL setting is the VvL voltage of the vertical transfer clock waveform, or the same voltage as the VL power supply for the V driver should be used.

\*2 Do not apply a DC bias to the substrate clock and reset gate clock pins, because a DC bias is generated within the CCD.

#### **DC Characteristics**

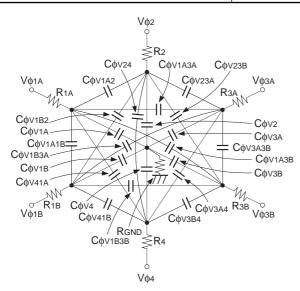
Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Supply current	Idd	2.0	4.5	7.0	mA	

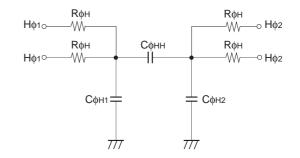
## **Clock Voltage Conditions**

ltem	Symbol	Min.	Тур.	Max.	Unit	Waveform diagram	Remarks
Readout clock voltage	Vvт	14.55	15.0	15.45	V	1	
	Vvh1, Vvh2	-0.05	0	0.05	V	2	Vvн = (Vvн1 + Vvн2)/2
	Vvнз, Vvн4	-0.2	0	0.05	V	2	
	Vvl1, Vvl2, Vvl3, Vvl4	-8.0	-7.5	-7.0	V	2	VvL = (VvL3 + VvL4)/2
	Vφv	6.8	7.5	8.05	V	2	$V\phi = V + n - V + n (n = 1 \text{ to } 4)$
Vertical transfer clock	Vvнз — Vvн	-0.25		0.1	V	2	
voltage	Vvh4 – Vvh	-0.25		0.1	V	2	
	V∨нн			0.6	V	2	High-level coupling
	Vvhl			0.9	V	2	High-level coupling
	Vvlh			0.9	V	2	Low-level coupling
	Vvll			0.5	V	2	Low-level coupling
	Vфн	4.75	5.0	5.25	V	3	
Horizontal transfer clock voltage	Vhl	-0.05	0	0.05	V	3	
clock voltage	Vcr	0.8	2.5		V	3	Cross-point voltage
	Vørg	3.0	3.3	5.25	V	4	
Reset gate clock voltage	Vrglh – Vrgll			0.4	V	4	Low-level coupling
, indigo	Vrgl – Vrglm			0.5	V	4	Low-level coupling
Substrate clock voltage	Vфsub	21.5	22.5	23.5	V	5	

## **Clock Equivalent Circuit Constant**

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
	Сфила, Сфиза		1500		pF	
Capacitance between vertical transfer clock and GND	Сфv1в, Сфv3в		5600		pF	
	<b>C</b> φν2, <b>C</b> φν4		2700		pF	
	<b>C</b> φν1Α2, <b>C</b> φν3Α4		390		pF	
	Сфv1в2, Сфv3в4		470		pF	
	Сфv2за, Сфv41а		120		pF	
	Сфv23в, Сфv41в		180		pF	
Capacitance between vertical transfer clocks	Сфилаза		39		pF	
	Сфv1взв		220		pF	
	Сфилазв, Сфилвза		62		pF	
	Сф∨24		75		pF	
	Сфv1а1в, Сфvзазв		68		pF	
Capacitance between horizontal transfer clock and GND	Сфн1, Сфн2		36.5		pF	
Capacitance between horizontal transfer clocks	Сфнн		88.5		pF	
Capacitance between reset gate clock and GND	Cørg		8		pF	
Capacitance between substrate clock and GND	Сфѕив		1000		pF	
Vertical transfer clock series resistor	R1A, R1B, R2, R3A, R3B, R4		62		Ω	
Vertical transfer clock ground resistor	Rgnd		18		Ω	
Horizontal transfer clock series resistor	Rфн		15		Ω	



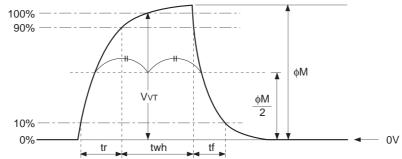


Vertical transfer clock equivalent circuit

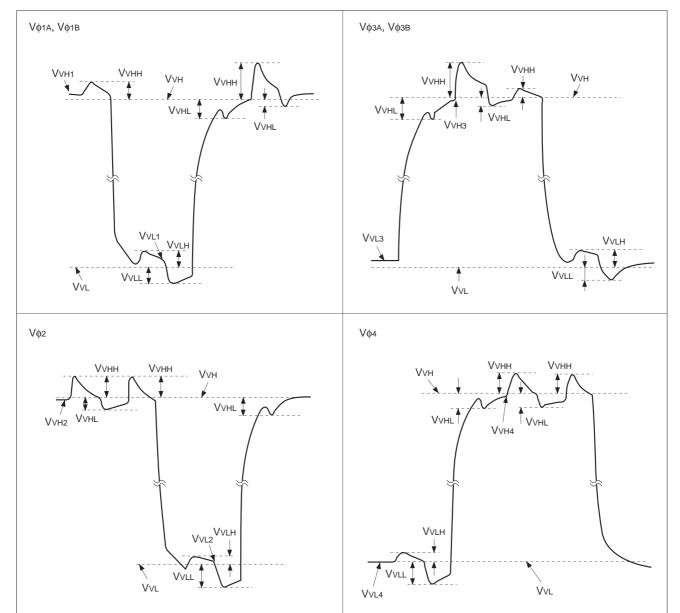
Horizontal transfer clock equivalent circuit

## **Drive Clock Waveform Conditions**

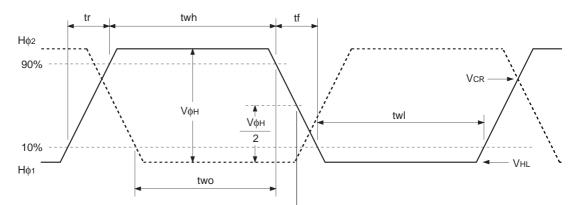
#### (1) Readout clock waveform





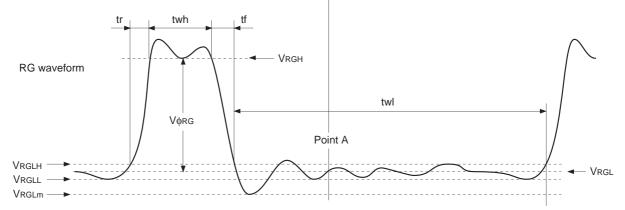


#### (3) Horizontal transfer clock waveform



Cross-point voltage for the H $\phi_1$  rising side of the horizontal transfer clocks H $\phi_1$  and H $\phi_2$  waveforms is Vcr. The overlap period for twh and twl of horizontal transfer clocks H $\phi_1$  and H $\phi_2$  is two.

#### (4) Reset gate clock waveform



VRGLH is the maximum value and VRGLL is the minimum value of the coupling waveform during the period from Point A in the above diagram until the rising edge of RG.

In addition, VRGL is the average value of VRGLH and VRGLL.

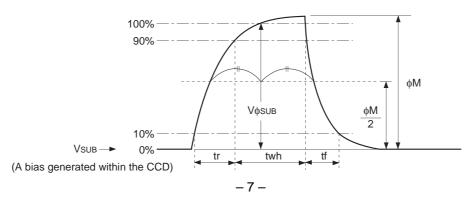
VRGL = (VRGLH + VRGLL)/2

Assuming VRGH is the minimum value during the interval twh, then:

Vørg = Vrgh – Vrgl

Negative overshoot level during the falling edge of RG is VRGLm.

#### (5) Substrate clock waveform

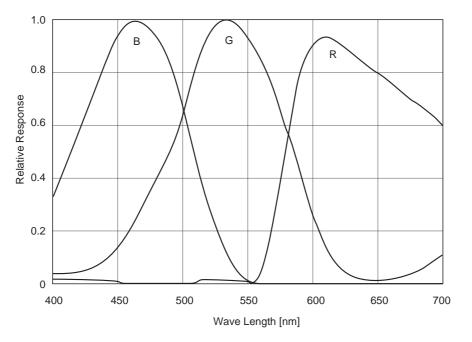


	ltom	Symbol		twh			twl			tr			tf		Unit	Remarks
	Item Symbol		Min.	Тур.	Max.	Unit	Remarks									
Rea	dout clock	VT	2.63	2.83						0.5			0.5		μs	During readout
Vert cloc	ical transfer k	Vφ1Α, Vφ1Β, Vφ2, Vφ3Α, Vφ3Β, Vφ4										15		250	ns	When using CXD3400N
с К	During	Hφ1	14	19.5		14	19.5			8.5	14		8.5	14	ns	$tf \ge tr - 2ns$
ntal r clc	imaging	Hø2	14	19.5		14	19.5			8.5	14		8.5	14		
Horizontal transfer clock	During parallel-serial	Hφ1		6.67						0.01			0.01			
Hc tra	conversion	Hø2					5.56			0.01			0.01		μs	
Res	et gate clock	φRG	7	10			37			4			5		ns	
Sub	strate clock	фSUB	1.7	3.06							0.5			0.5	μs	During drain charge

# Clock Switching Characteristics (Horizontal drive frequency: 18MHz)

ltom	Quanta	two			Linit	Remarks	
Item	Symbol	Min.	Тур.	Max.	Unit	Remarks	
Horizontal transfer clock	Hφ1, Hφ2	12	19.5		ns		

# Spectral Sensitivity Characteristics (excludes lens characteristics and light source characteristics)



Item		Symbol	Min.	Тур.	Max.	Unit	Measurement method	Remarks
G sensitivity	G sensitivity		220	270		mV	1	1/30s accumulation
Sensitivity	R	Rr	0.3	0.45	0.6		1	
comparison	В	Rb	0.35	0.50	0.65		1	
Saturation signal		Vsat	450			mV	2	Ta = 60°C,*1
Smoor	Smear			-89.1	-81.2	dB	3	Frame readout mode,*2
Smear				-79.6	-71.6	uр	3	High frame rate readout mode
Video oignol obs	dina	СЦа			20	%		Zone 0 and I
Video signal sha	ung	SHg			25	70	4	Zone 0 to II'
Dark signal		Vdt			12	mV	5	Ta = 60°C, 4.28 frame/s
Dark signal shad	ding	ΔVdt			6	mV	6	Ta = 60°C, 4.28 frame/s,*3
Line crawl G		Lcg			3.8	%	7	
Line crawl R		Lcr			3.8	%	7	
Line crawl B		Lcb			3.8	%	7	
Lag		Lag			0.5	%	8	

**Image Sensor Characteristics** (Horizontal drive frequency: 18MHz)

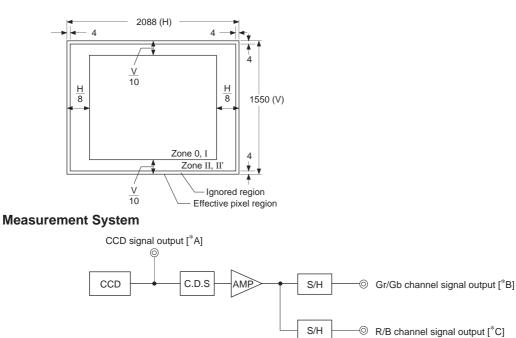
(Ta = 25°C)

\*1 The saturation signal level is 450mV or more by performing pull-down C<sub>SUB</sub> pin at 1.3kΩ resistor. For high frame rate readout mode, it is 800mV.

\*2 After closing the mechanical shutter, the smear can be reduced to below the detection limit by performing vertical register sweep operation.

\*3 Excludes vertical dark signal shading caused by vertical register high-speed transfer.

#### Zone Definition of Video Signal Shading



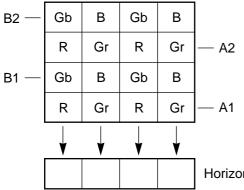
Note) Adjust the amplifier gain so that the gain between [\*A] and [\*B], and between [\*A] and [\*C] equals 1.

## Image Sensor Characteristics Measurement Method

#### O Measurement conditions

- 1) In the following measurements, the device drive conditions are at the typical values of the bias and clock voltage conditions, and the frame readout mode is used.
- 2) In the following measurements, spot blemishes are excluded and, unless otherwise specified, the optical black level (OB) is used as the reference for the signal output, which is taken as the value of the Gr/Gb channel signal output or the R/B channel signal output of the measurement system.

#### ◎ Color coding of this image sensor & Readout



The primary color filters of this image sensor are arranged in the layout shown in the figure on the left (Bayer arrangement).

Gr and Gb denote the G signals on the same line as the R signal and the B signal, respectively.

For frame readout, the A1 and A2 lines are output as signals in the A field, and the B1 and B2 lines in the B field.

Horizontal register

**Color Coding Diagram** 

#### Readout modes

#### 1. Readout modes list

The following readout modes are possible by driving the image sensor at the timing specifications noted in this Data Sheet.

Mode name	9	Frame rate	Number of output effective lines
Frame readout mode	NTSC mode	4.28 frame/s	1550 (Odd 775, Even 775)
Frame readout mode	PAL mode	4.16 frame/s	1550 (Odd 775, Even 775)
High frame rate readout mode	NTSC mode	30 frame/s	258
	PAL mode	25 frame/s	258
AF1 mode	NTSC mode	60 frame/s	See Page.12
AFTMODE	PAL mode	50 frame/s	See Page.12
AF2 mode	NTSC mode	120 frame/s	See Page.12
AF2 mode	PAL mode	100 frame/s	See Page.12

#### 2. Frame readout mode, high frame rate readout mode

Frame rea	Frame readout mode							
1st field	2nd field	High frame rate readout mode						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$						

Note) Blacked out portions in the diagram indicate pixels which are not read out.

1. Frame readout mode

In this mode, all pixel signals are divided into two fields and output.

All pixel signals are read out independently, making this mode suitable for high resolution image capturing.

2. High frame rate readout mode

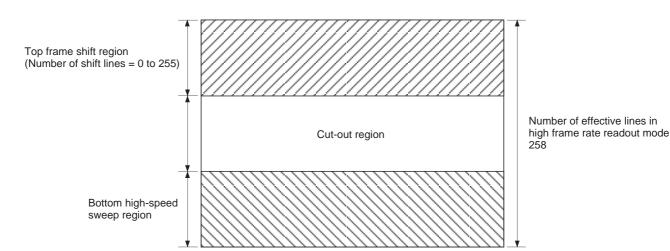
Output is performed at 30 frames per second by reading out 4 pixels for every 12 vertical pixels and adding 2 pixels in the horizontal CCD.

The number of output lines is 258 lines.

This readout mode emphasizes processing speed over vertical resolution.

## 3. AF1 mode, AF2 mode

The AF modes increase the frame rate by cutting out a portion of the picture through high-speed elimination of the top and bottom of the picture in high frame rate readout mode. AF1 allows 1/60s and 1/50s output, and AF2 allows 1/120s and 1/100s output, so these modes are effective for raising the auto focus (AF) speed. In addition, the cut-out can begin from an optional line by controlling the number of frame shift lines that sweep the top of the picture. The relation between the number of frame shift lines, the output start position and number of output lines is shown in the table below.



	AF1	mode	AF2 mode				
	NTSC	PAL	NTSC	PAL			
Frame rate	1/60s	1/50s	1/120s	1/100s			
Output start position on timing chart	26H	26H	30H	30H			
Number of frame shift lines	i = 0 to 255						
Output lines*1	i + 3 to i + 108 i + 3 to i + 134 i + 3 to i + 38 i + 3 to						

\*1 Output line is Up to 258 lines.

The i + 1 and i + 2 line signals may be disrupted by elimination of the picture top, so these lines should not be used.

For example, if the picture top is eliminated with i = 100 in AF1 mode (NTSC), lines 103 to 208 in high frame rate readout mode are output from 26H of the timing chart.

If the picture top is eliminated with i = 160 in AF1 mode (NTSC), lines 163 to 258 in high frame rate readout mode are output from 26H of the timing chart.

#### ◎ Definition of standard imaging conditions

1) Standard imaging condition I:

Use a pattern box (luminance: 706cd/m<sup>2</sup>, color temperature of 3200K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F5.6. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

2) Standard imaging condition II:

Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

3) Standard imaging condition III:

Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens (exit pupil distance -33mm) with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

#### 1. G sensitivity, sensitivity comparison

Set to standard imaging condition I. After selecting the electronic shutter mode with a shutter speed of 1/100s, measure the signal outputs (V<sub>Gr</sub>, V<sub>Gb</sub>, V<sub>R</sub> and V<sub>B</sub>) at the center of each Gr, Gb, R and B channel screen, and substitute the values into the following formulas.

$$\label{eq:VG} \begin{split} VG &= (VGr + VGb)/2\\ Sg &= VG \times 100/30 \; [mV]\\ Rr &= VR/VG\\ Rb &= VB/VG \end{split}$$

2. Saturation signal

Set to standard imaging condition II. After adjusting the luminous intensity to 20 times the intensity with the average value of the Gr signal output, 150mV, measure the minimum values of the Gr, Gb, R and B signal outputs.

3. Smear

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, first adjust the average value of the Gr signal output to 150mV. Measure the average values of the Gr signal output, Gb signal output, R signal output and B signal output (Gra, Gba, Ra, Ba), and then adjust the luminous intensity to 500 times the intensity with the average value of the Gr signal output, 150mV. After the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value (Vsm [mV]) independent of the Gr, Gb, R and B signal outputs, and substitute the values into the following formula.

$$Sm = 20 \times log \left(Vsm \div \frac{Gra + Gba + Ra + Ba}{4} \times \frac{1}{500} \times \frac{1}{10}\right) \text{ [dB] (1/10V method conversion value)}$$

4. Video signal shading

Set to standard imaging condition III. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity so that the average value of the Gr signal output is 150mV. Then measure the maximum (Grmax [mV]) and minimum (Grmin [mV]) values of the Gr signal output and substitute the values into the following formula.

SHg =  $(Grmax - Grmin)/150 \times 100$  [%]

## 5. Dark signal

Measure the average value of the signal output (Vdt [mV]) with the device ambient temperature 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as a reference.

## 6. Dark signal shading

After measuring 5, measure the maximum (Vdmax [mV]) and minimum (Vdmin [mV]) values of the dark signal output and substitute the values into the following formula.

 $\Delta V dt = V dmax - V dmin [mV]$ 

## 7. Line crawl

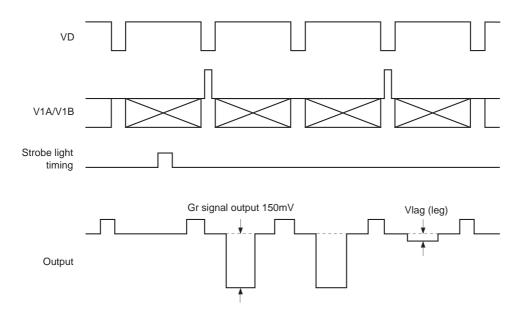
Set to standard imaging condition II. Adjusting the luminous intensity so that the average value of the Gr signal output is 150mV, and then insert R, G and B filters and measure the difference between G signal lines ( $\Delta$ Glr,  $\Delta$ Glg,  $\Delta$ Glb [mV]) as well as the average value of the G signal output (Gar, Gag, Gab). Substitute the values into the following formula.

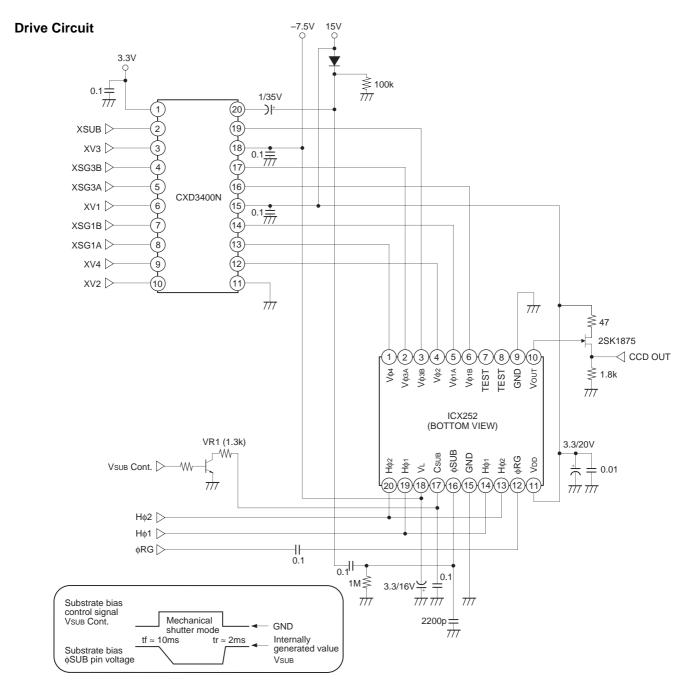
 $Lci = \frac{\Delta Gli}{Gai} \times 100 \text{ [\%]} (i = r, g, b)$ 

## 8. Lag

Adjust the Gr signal output value generated by strobe light to 150mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal (Vlag). Substitute the value into the following formula.

Lag = (Vlag/150) × 100 [%]





#### Notes)

Substrate bias control

- 1. The saturation signal level decreases when exposure is performed using the mechanical shutter, so control the substrate bias.
- 2. A saturation signal level equivalent to that for continuous exposure can be assured by connecting a  $1.3k\Omega$  grounding resistor to the CCD Csub pin.

Drive timing precautions

- 1. Blooming occurs in modes (high frame rate readout, etc.) that do not use the mechanical shutter, so do not ground the connected  $1.3k\Omega$  resistor.
- tf is slow, so the internally generated voltage VsuB may not drop to a sufficiently low level if the substrate bias control signal is not set to high level 40ms before entering the exposure period and the 1.3kΩ resistor connected to the CsuB pin is not grounded.

Act.	High frame rate readout mode	Exposure operation	Frame readout mode	High frame rate readout mode
VD				
V1A				
V1B				
V2		-		
V3A				
V3B				
V4				
SUB	A A A	C V M		
TRG				
Mechanical shutter	OPEN	CLOSE		OPEN
Vsub Cont.				
CCD	A output signal A output signal B output signal B output signal		C output signal (ODD) C output signal (EVEN)	VEN) Output after frame readout D output signal E output signal

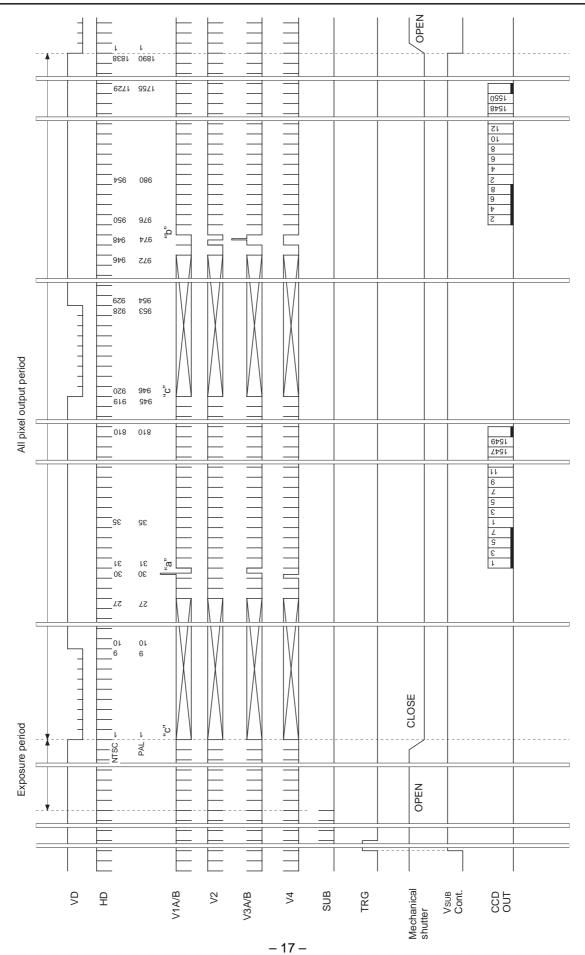
- 16 -

Note) The B output signal contains a blooming component and should therefore not be used.

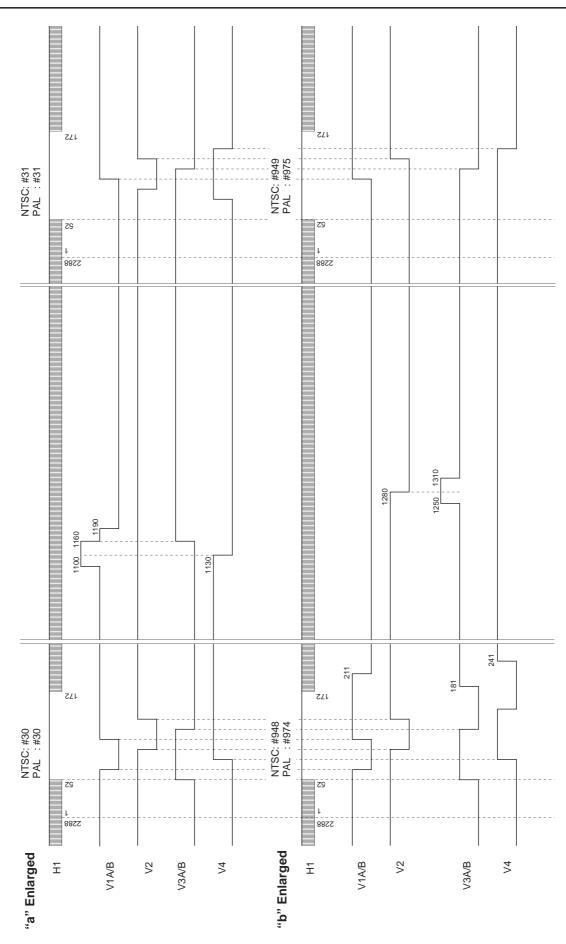
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Drive Timing Chart (Vertical Sync) NTSC

NTSC/PAL Frame Readout Mode NTSC: 4.28 frame/s, PAL: 4.17 frame/s

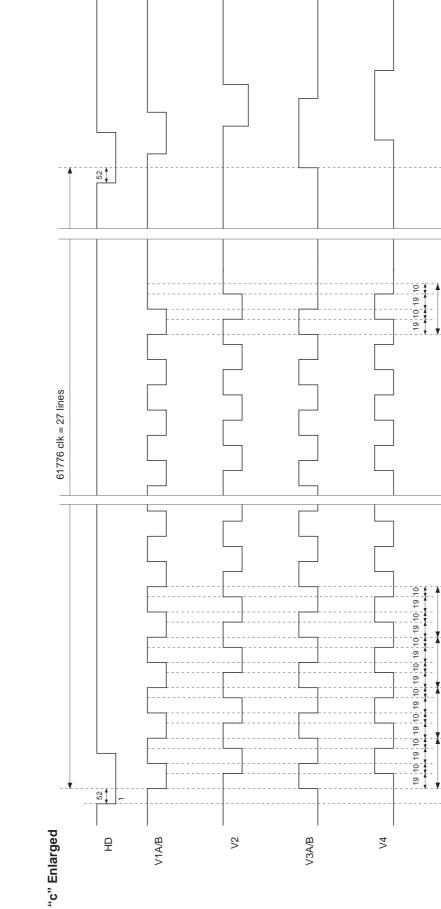


Note) 2288fH, However, 919H and 1828H in NTSC mode are 1716 clk, and 944H, 945H, 1889H and 1890H in PAL mode are 1208 clk.



Drive Timing Chart (Readout) NTSC/PAL Frame Readout Mode

– 18 –



Drive Timing Chart (High-speed Sweep Operation) NTSC/PAL Frame Readout Mode

#1038

#2 #3 #4

- **-**

– 19 –

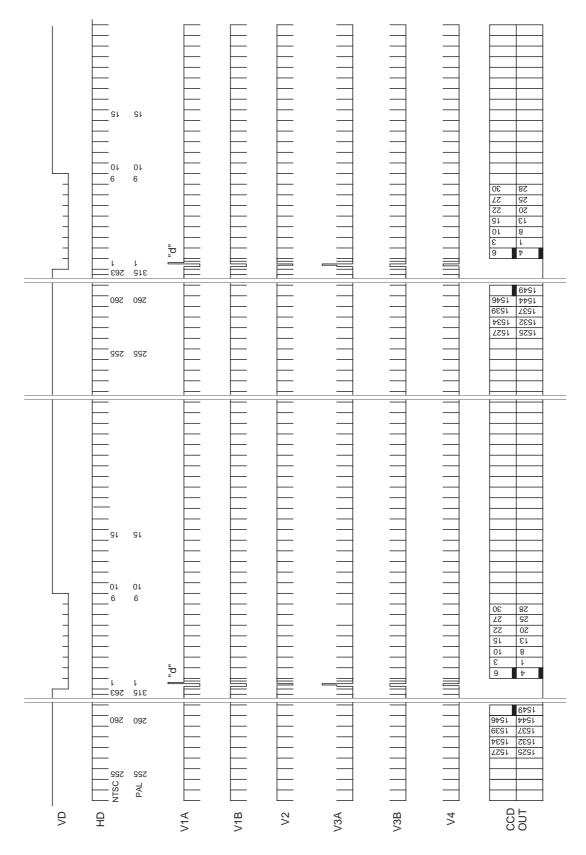
					2				
Ignored pixel 4 bits									
Ignoi CLK	RG	CHP CHP	V1A/B	V2	V3A/B	V4	H1	H2 SUB	



– 20 –

Drive Timing Chart (Vertical Sync) I

NTSC/PAL High Frame Rate Readout Mode NTSC: 30 frame/s, PAL: 25 frame/s

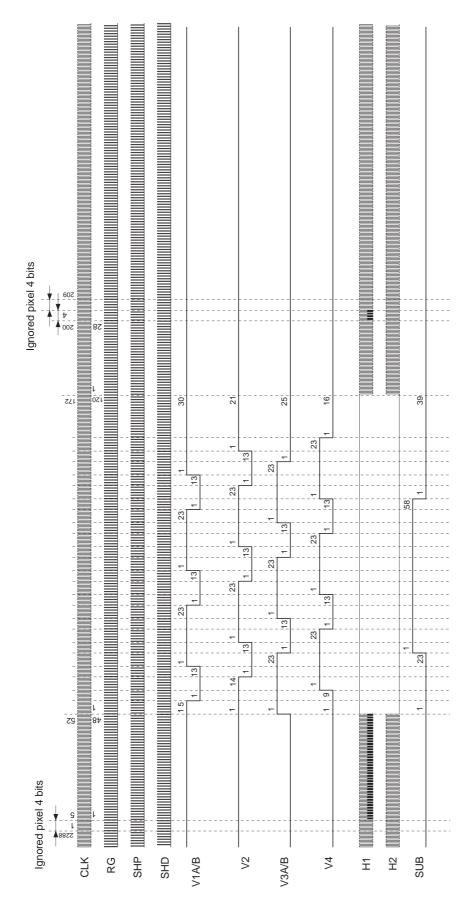


#2	NTSC 2288 1 PAL 2288 1 PAL 2288 1							
		1040 1250 1310		1130 1220 1370 1430	100 1160		1280	
#1	6 1144 1 1568 1 5588 1 558 1 5							
"d" Enlarged	T - NTSC PAL	V1A	V1B	V2	V3A - 25	V3B	٧4	

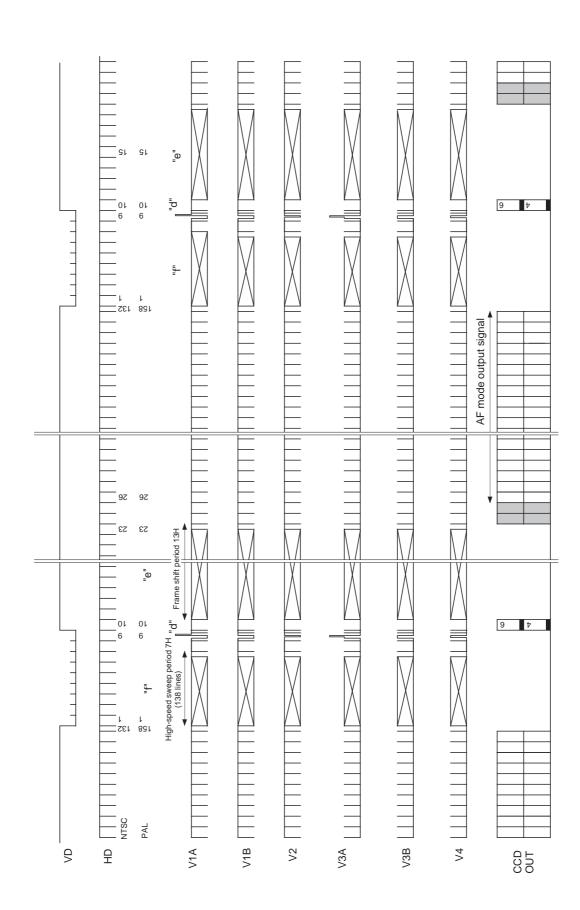
Drive Timing Chart (Readout) NTSC/PAL High Frame Rate Readout Mode

- 22 -

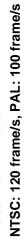
, AF2 Mode
1 Mode
e, AF
t Mode
Readou
e Rate
Frame
- High
NTSC/PAL
Sync)
izontal
(Hor
Chart
Timing
Drive

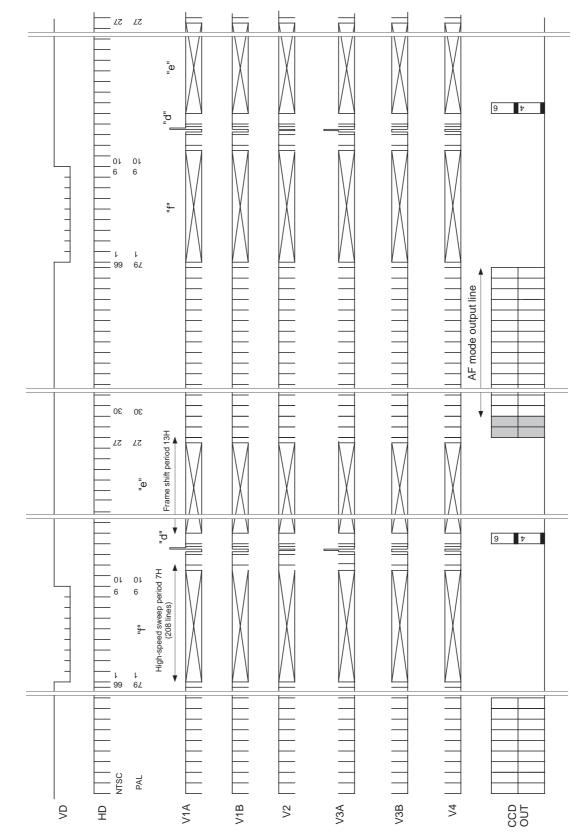


- 23 -



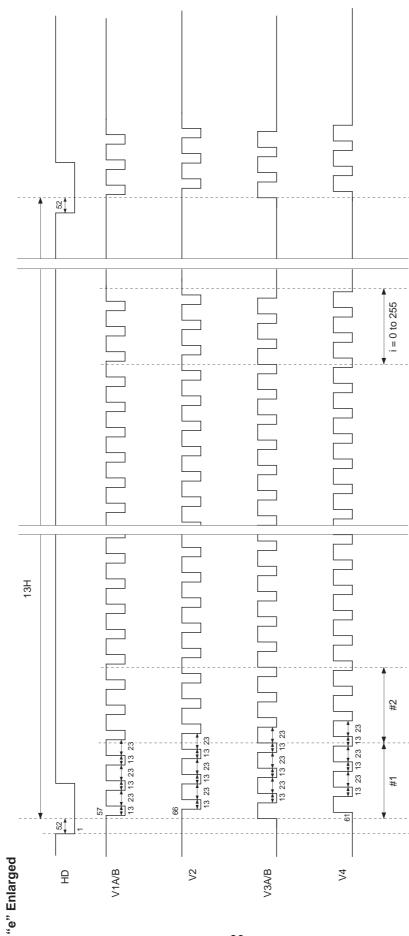
Note) 2288fH, However, 182H in NTSC mode is 572 clk, and 158H in PAL mode is 784 clk.

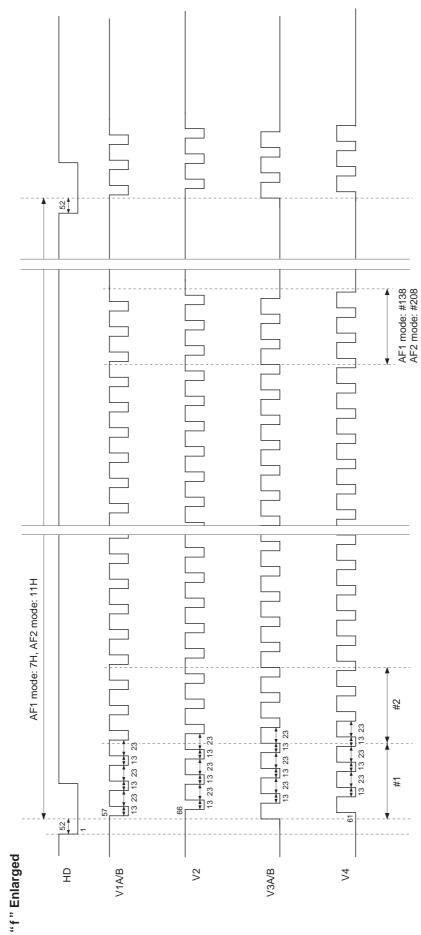




Note) 2288fH, However, 66H in NTSC mode is 1430 clk, and 79H in PAL mode is 1356 clk.







SONY

- 27 -

## **Notes on Handling**

1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

- a) Either handle bare handed or use non-chargeable gloves, clothes or material.
  - Also use conductive shoes.
- b) When handling directly use an earth band.
- c) Install a conductive mat on the floor or working table to prevent the generation of static electricity.
- d) Ionized air is recommended for discharge when handling CCD image sensors.
- e) For the shipment of mounted substrates, use boxes treated for the prevention of static charges.

## 2) Soldering

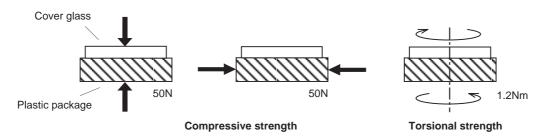
- a) Make sure the package temperature does not exceed 80°C.
- b) Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a ground 30W soldering iron and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
- c) To dismount an image sensor, do not use a solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero-cross On/Off type and connect it to ground.
- 3) Dust and dirt protection

Image sensors are packed and delivered by taking care of protecting its glass plates from harmful dust and dirt. Clean glass plates with the following operations as required, and use them.

- a) Perform all assembly operations in a clean room (class 1000 or less).
- b) Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface, blow it off with an air blower. (For dirt stuck through static electricity ionized air is recommended.)
- c) Clean with a cotton bud and ethyl alcohol if grease stained. Be careful not to scratch the glass.
- d) Keep in a case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- e) When a protective tape is applied before shipping, just before use remove the tape applied for electrostatic protection. Do not reuse the tape.

## 4) Installing (attaching)

a) Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)



b) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the bottom of the package. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

- c) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to other locations as a precaution.
- d) The notch of the package is used for directional index, and that can not be used for reference of fixing. In addition, the cover glass and seal resin may overlap with the notch of the package.
- e) If the leads are bent repeatedly and metal, etc., clash or rub against the package, the dust may be generated by the fragments of resin.
- f) Acrylate anaerobic adhesives are generally used to attach CCD image sensors. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives. (reference)

## 5) Others

- a) Do not expose to strong light (sun rays) for long periods, as color filters will be discolored. When high luminous objects are imaged with the exposure level controlled by the electronic iris, the luminance of the image-plane may become excessive and discoloring of the color filter will possibly be accelerated. In such a case, it is advisable that taking-lens with the automatic-iris and closing of the shutter during the poweroff mode should be properly arranged. For continuous using under cruel condition exceeding the normal using condition, consult our company.
- b) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.
- c) Brown stains may be seen on the bottom or side of the package. But this does not affect the CCD characteristics.

			<b>"A</b> " is the center of the effective image area. The two points <b>"B</b> " of the package are the horizontal reference. The point <b>"B</b> " of the package is the vertical reference. The bottom <b>"C</b> " of the package, and the top of the cover glass <b>"D</b> " are the height reference. The center of the effective image area relative to <b>"B</b> " and <b>"B</b> "	The rotation angle of the effective image area relative to H and V is $\pm 1^{\circ}$ .	The height from the bottom "C" to the effective image area is 1.41 $\pm$ 0.10mm. The height from the top of the cover glass "D" to the effective image area is 1.49 $\pm$ 0.15mm.	The tilt of the effective image area relative to the bottom "C" is less than 50µm.	The tilt of the effective image area relative to the top "D" of the cover glass is less than 50µm.	The thickness of the cover glass is 0.5mm, and the refractive index is 1.5.	
	20pin DIP	C 10.9	8.0 0.1 0.1 0.1 0.1 0.0 0.0 0.0 0	2.	<ol> <li>The height from the bottom "C" 1</li> <li>The height from the top of the co</li> </ol>	7. The tilt of the effective image ar	The tilt of the effective image are	8. The thickness of the cover glass	
Unit: mm		6:0 20 1.3.8 ± 0.1 1.3.8 ± 0.1	10.0 2.5 1.27	-	Plastic	GOLD PLATING	42 ALLOY	0.95g	
Package Outline Ur		0.5 0.5 0.5 0.5 0.5 0.5 0.5 0.5 0.5 0.5		PACKAGE STRUCTURE	PACKAGE MATERIAL	LEAD TREATMENT	LEAD MATERIAL	PACKAGE MASS	